

FDD5202P-VB Datasheet

P-Channel 60-V (D-S) MOSFET

PRODUC	PRODUCT SUMMARY				
V _{DS} (V)	R_{DS(on)} (Ω)	I _D (A)	Q _g (Typ)		
- 60	0.061 at V _{GS} = - 10 V	- 30	10		
- 00	0.072 at V _{GS} = - 4.5 V	- 25	10		

FEATURES

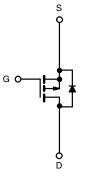
- Trench Power MOSFET
- 100 % UIS Tested

APPLICATIONS

Load Switch







P-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Gate-Source Voltage	V _{GS}	± 20	V		
Continuous Drain Current ($T_1 = 175 ^{\circ}C$)	T _C = 25 °C	1-	- 30		
Continuous Drain Current $(1) = 175$ C)	T _C = 100 °C	ID –	- 25	1	
Pulsed Drain Current	I _{DM}	- 30	А		
Continuing Source Current (Diode Conduction)	۱ _S	- 20			
Avalanche Current	I _{AS}	- 20			
Single Pulse Avalanche Energy	L = 0.1 mH	E _{AS}	7.2	mJ	
Maximum Dawar Dissinction	T _C = 25 °C	В	34 ^a	w	
Maximum Power Dissipation	T _A = 25 °C	P _D	4 ^b	~ ~ ~	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
hundling to Anching b	t ≤ 10 sec	D	20	25	
Junction-to-Ambient ^D	Steady State	R _{thJA}	62	75	°C/W
Junction-to-Case		R _{thJC}	5	6	

Notes:

a. See SOA curve for voltage derating.

b. Surface Mounted on 1" x 1" FR-4 boad.

$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	SPECIFICATIONS $T_J = 25$	°C, unless	otherwise noted					
$ \begin{array}{c c c c c c c } \hline \begin{tabular}{ c c c c c } \hline \begin{tabular}{ c c c c c } \hline \begin{tabular}{ c c c c } \hline \begin{tabular}{ c c c c } \hline \begin{tabular}{ c c c c c c } \hline \begin{tabular}{ c c c c c c } \hline \begin{tabular}{ c c c c c c c } \hline \begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	Parameter	Symbol	Test Conditions	Min	Typ ^a	Max	Unit	
Gate Threshold Voltage V _{GS(m)} V _{DS} = V _{GS} , b = -250 µA -1.0 -2.0 -3.0 V Gate-Body Leakage I _{GSS} V _{DS} = 0 V, V _{GS} = 20 V ± 100 nA Zero Gate Voltage Drain Current I _{DSS} V _{DS} = -60 V, V _{GS} = 0 V -1 +100 -1 Zero Gate Voltage Drain Current I _{DSS} V _{DS} = -60 V, V _{GS} = 0 V -1 +100 nA Zero Gate Voltage Drain Current I _{DSS} V _{DS} = -60 V, V _{GS} = 0 V -1 +100 nA On-State Drain Current ^b Ip(m) V _{DS} = -50 V, V _{GS} = 0 V -10 -10 A V _{DS} = -50 V, V _{GS} = 0 V, T _J = 125 °C 0.061 V _{DS} = -50 V, V _{GS} = -10 V, Ip = -5 A 0.061 P On-State Drain Current ^b Ip(m) V _{DS} = -50 V, V _{GS} = -10 V, Ip = -5 A 0.061 P V _{DS} = -10 V, Ip = -5 A V _{DS} = -5 V, V _{ID} = -2 A 0.0072 P Forward Transconductance ^b 918 V _{DS} = -15 V, Ip = -5 A 8 S Output Capacitance C _{ciss} 1000 P Gate-Drain Charge Q _g <td>Static</td> <td>•</td> <td>· · · ·</td> <td></td> <td></td> <td>•</td> <td>•</td>	Static	•	· · · ·			•	•	
$ \begin{array}{c c c c c c c } \hline \mbox{Gate Threshold Voltage} & V_{GS}(h) & V_{DS} = V_{GS}, h_{D} = -250 \ \mu & -1.0 & -2.0 & -3.0 \\ \hline \mbox{Gate-Body Leakage} & l_{GSS} & V_{DS} = 0 \ V, V_{GS} = 20 \ V & \pm 100 & nA \\ \hline \mbox{VDS} = -60 \ V, V_{GS} = 0 \ V & V_{GS} = 0 \ V & V_{GS} = -50 & V_{GS} & 0 \\ \hline \mbox{VDS} = -60 \ V, V_{GS} = 0 \ V, T_{J} = 125 \ ^{\circ} C & -10 & -10 \\ \hline \mbox{VDS} = -60 \ V, V_{GS} = 0 \ V, T_{J} = 125 \ ^{\circ} C & -10 & -10 & A \\ \hline \mbox{VDS} = -60 \ V, V_{GS} = 0 \ V, T_{J} = 175 \ ^{\circ} C & 0.100 & -10 & A \\ \hline \mbox{VDS} = -10 \ V, l_{D} = -5 \ A, \ T_{J} = 125 \ ^{\circ} C & 0.100 & -10 & -20 & -10 \\ \hline \mbox{VDS} = -10 \ V, l_{D} = -5 \ A, \ T_{J} = 125 \ ^{\circ} C & 0.100 & -10 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -20 & -$	Drain-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 V, I_D = -250 \mu A$	- 60			V	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = -250 \ \mu A$	- 1.0	- 2.0	- 3.0	v	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$			$V_{DS} = -60 V, V_{GS} = 0 V$			- 1		
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Zero Gate Voltage Drain Current	I _{DSS}	V_{DS} = - 60 V, V_{GS} = 0 V, T_{J} = 125 °C			- 50	μΑ	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $			V_{DS} = - 60 V, V_{GS} = 0 V, T_{J} = 175 °C			- 150	μA A Ω S pF nC	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	On-State Drain Current ^b	I _{D(on)}	V _{DS} = - 5 V, V _{GS} = - 10 V	- 10			А	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $			V _{GS} = - 10 V, I _D = - 5 A		0.061			
$ \begin{array}{ c c c c c c } \hline \begin{tabular}{ c c c c c } \hline \begin{tabular}{ c c c c } \hline \begin{tabular}{ c c c c c } \hline \begin{tabular}{ c c c c c c } \hline \hline \begin{tabular}{ c c c c c c } \hline \hline \begin{tabular}{ c c c c c c c } \hline \hline \begin{tabular}{ c c c c c c c } \hline \hline \begin{tabular}{ c c c c c c c } \hline \hline \begin{tabular}{ c c c c c c c } \hline \hline \begin{tabular}{ c c c c c c c c c c c c c c c c c c c$		r	V_{GS} = - 10 V, I_D = - 5 A, T_J = 125 °C		0.100		6	
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	Drain-Source On-State Resistance	DS(on)	V_{GS} = - 10 V, I_D = - 5 A, T_J = 175 °C		0.150		52	
Dynamic 100 1000 pF Output Capacitance C_{iss} $V_{DS} = -25 V, V_{GS} = 0 V, f = 1 MHz$ 1000 pF Reverse Transfer Capacitance C_{rss} 100 100 nC Total Gate Charge Q_g 0_{Qgs} $V_{DS} = -30 V, V_{GS} = -10 V, I_D = -8.4 A$ 2.1 nC Gate-Source Charge Q_{gd} $V_{DS} = -30 V, V_{GS} = -10 V, I_D = -8.4 A$ 2.1 nC Gate Point Charge Q_{gd} $V_{DS} = -30 V, V_{GS} = -10 V, I_D = -8.4 A$ 2.1 nC Gate Resistance R_g $f = 1 MHz$ 8.0 Ω Turn-On Delay Time ^C $t_d(on)$ $I_D = -30 V, R_L = 3.57 \Omega$ $I15$ ns Rise Time ^C t_r $I_D = -8.4 A, V_{GEN} = -10 V, R_G = 2.5 \Omega$ $I6$ ns Source-Drain Diode Ratings and Characteristics $(T_C = 25 °C)^{D}$ $I6$ -30 A Pulsed Current I_{SM} $I_F = -2 A, V_{GS} = 0 V$ -0.9 -1.3 V Reverse Recovery Time t_{rr} $I_F = -8 A, di/dt = 100 A/us$ 50			V _{GS} = - 4.5 V, I _D = - 2 A		0.072		1	
$ \begin{array}{c c c c c c c c c } \mbox{Input Capacitance} & C_{1SS} & & & & & & & & & & & & & & & & & & $	Forward Transconductance ^b	9 _{fs}	V _{DS} = - 15 V, I _D = - 5 A		8		S	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Dynamic	•	• • •		•	•	•	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Input Capacitance	C _{iss}			1000			
$ \begin{array}{c c c c c c c c } \hline Total Gate Charge & Q_g \\ \hline Gate-Source Charge & Q_{gd} \\ \hline Gate-Drain Charge & Q_{gd} \\ \hline Gate Resistance & R_g & f = 1 \ MHz & 8.0 & 0 \\ \hline Gate Resistance & R_g & f = 1 \ MHz & 8.0 & 0 \\ \hline Turn-On \ Delay \ Time^{C} & t_{d(on)} \\ \hline Rise \ Time^{C} & t_{d(off)} \\ \hline Turn-Off \ Delay \ Time^{C} & t_{d(off)} \\ \hline Fall \ Time^{C} & t_{f} \\ \hline \hline Source-Drain \ Diode \ Ratings \ and \ Characteristics & (T_C = 25 \ C)^{b} \\ \hline Pulsed \ Current & I_{SM} & I_F = -2 \ A, \ V_{GS} = 0 \ V & -0.9 & -1.3 & V \\ \hline Reverse \ Recovery \ Time & t_{rr} & I_F = -8 \ A, \ di/dt = 100 \ A/us & 50 & ns \\ \hline \end{array} $	Output Capacitance	C _{oss}	V_{DS} = - 25 V, V_{GS} = 0 V, f = 1 MHz		120		pF	
Gate-Source Charge O_{gs} $V_{DS} = -30 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -8.4 \text{ A}$ 2.1 nC Gate-Drain Charge O_{gd} 3.2 3.2 3.2 0 Gate Resistance R_g $f = 1 \text{ MHz}$ 8.0 Ω Ω Turn-On Delay Time ^c $t_{d(on)}$ $V_{DD} = -30 \text{ V}, R_L = 3.57 \Omega$ 15 nS Turn-Off Delay Time ^c t_r $V_{DD} = -30 \text{ V}, R_G = 2.5 \Omega$ 16 nS Fall Time ^c t_f $V_{CS} = -10 \text{ V}, R_G = 2.5 \Omega$ 16 nS Source-Drain Diode Ratings and Characteristics $(T_C = 25 \text{ °C})^b$ -30 A A Pulsed Current I_{SM} $I_F = -2 \text{ A}, V_{GS} = 0 \text{ V}$ -0.9 - 1.3 V Reverse Recovery Time t_{rr} $I_F = -8 \text{ A}, di/dt = 100 \text{ A}/us$ 50 ns	Reverse Transfer Capacitance	C _{rss}			100			
$ \begin{array}{c c c c c c c c c } \hline Gate-Drain Charge & Q_{gd} & & & & & & & & & & & & & & & & & & &$	Total Gate Charge	Qg			10			
$ \begin{array}{c c c c c c c c } \hline Gate Resistance & R_g & f = 1 \ \text{MHz} & 8.0 & \Omega \\ \hline \mbox{Turn-On Delay Time}^c & t_{d(on)} \\ \hline \mbox{Rise Time}^c & t_r & V_{DD} = -30 \ \text{V}, \ \mbox{R}_L = 3.57 \ \Omega & 15 & 0 \\ \hline \mbox{Turn-Off Delay Time}^c & t_{d(off)} & I_D \cong -8.4 \ \mbox{A}, \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \$	Gate-Source Charge	Q _{gs}	$V_{DS} = -30$ V, $V_{GS} = -10$ V, $I_{D} = -8.4$ A		2.1		nC	
$ \begin{array}{c c c c c c c c } \hline Turn-On \ Delay \ Time^{c} & \hline t_{d(on)} \\ \hline Rise \ Time^{c} & \hline t_{r} \\ \hline Turn-Off \ Delay \ Time^{c} & \hline t_{d(off)} \\ \hline Tall \ Time^{c} & \hline t_{d(off)} \\ \hline Fall \ Time^{c} & \hline t_{f} \\ \hline \end{array} \\ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-Drain Charge	Q _{gd}			3.2		1	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate Resistance	Rg	f = 1 MHz		8.0		Ω	
$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	Turn-On Delay Time ^c	t _{d(on)}			6			
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Rise Time ^c	t _r	V_{DD} = - 30 V, R_L = 3.57 Ω		15			
Source-Drain Diode Ratings and Characteristics $(T_C = 25 \text{ °C})^b$ Pulsed Current I _{SM} - 30 A Forward Voltage ^b V _{SD} I _F = - 2 A, V _{GS} = 0 V - 0.9 - 1.3 V Reverse Recovery Time t_{rr} I _F = - 8 A, di/dt = 100 A/us 50 ns	Turn-Off Delay Time ^c	t _{d(off)}	$I_D \cong$ - 8.4 A, V_{GEN} = - 10 V, R_G = 2.5 Ω		16		115	
Pulsed CurrentI SMI Forward Voltageb- 30AForward VoltagebV SDI F F F FI F F F F F F F F 	Fall Time ^c	t _f]		8			
Forward Voltage ^b V_{SD} $I_F = -2 \text{ A}, V_{GS} = 0 \text{ V}$ -0.9 -1.3 V Reverse Recovery Time t_{rr} $I_F = -8 \text{ A}, di/dt = 100 \text{ A/us}$ 50ns	Source-Drain Diode Ratings and Cha	aracteristics	(T _C = 25 °C) ^b			•	•	
Reverse Recovery Time t_{rr} $l_r = -8 \text{ A. } di/dt = 100 \text{ A/us}$ 50ns	Pulsed Current	I _{SM}				- 30	А	
r = -8 A, di/dt = 100 A/us	Forward Voltage ^b	V _{SD}	I _F = - 2 A, V _{GS} = 0 V		- 0.9	- 1.3	V	
Reverse Recovery Time Q _{rr} 80 nC	Reverse Recovery Time	t _{rr}	$I_{} = 8.4$ di/dt $= 100.4/vc$		50		ns	
	Reverse Recovery Time	Q _{rr}	$F_{\rm F} = -6 \text{A}, \text{div} \text{dt} = 100 \text{Av} \mu \text{s}$		80		nC	

Notes:

a. Guaranteed by design, not subject to production testing.

b. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

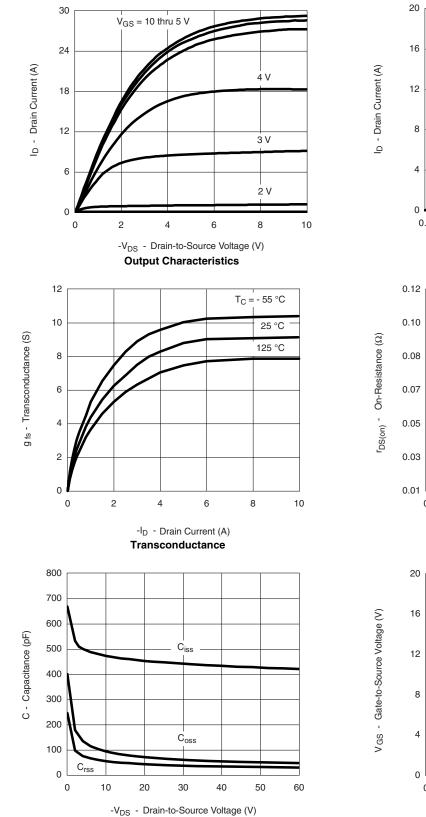
VBsemi VBsemi.com



125 °C

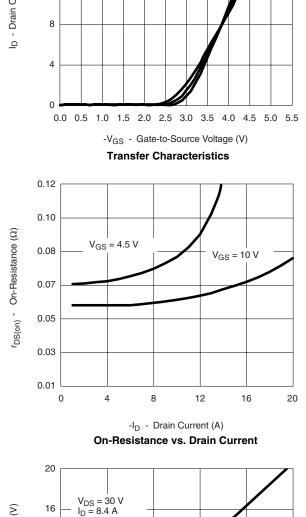
T_C = - 55 °C

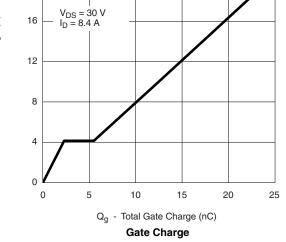
1 25 °C



Capacitance

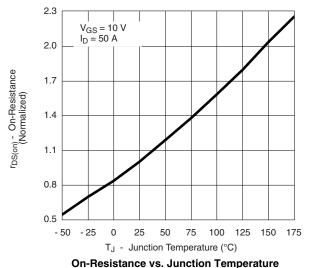
TYPICAL CHARACTERISTICS 25 °C unless noted



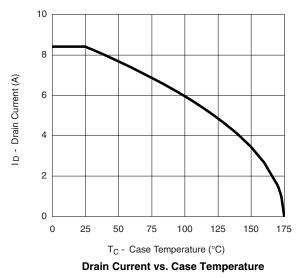


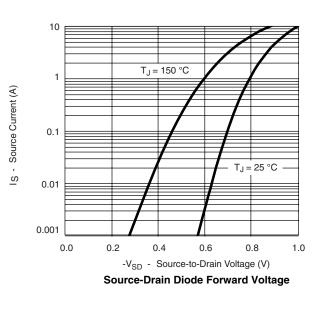
服务热线:400-655-8788

TYPICAL CHARACTERISTICS 25 °C unless noted



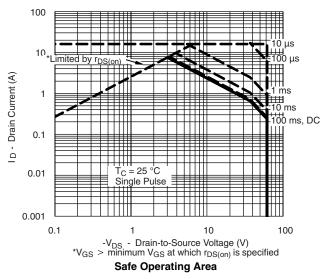






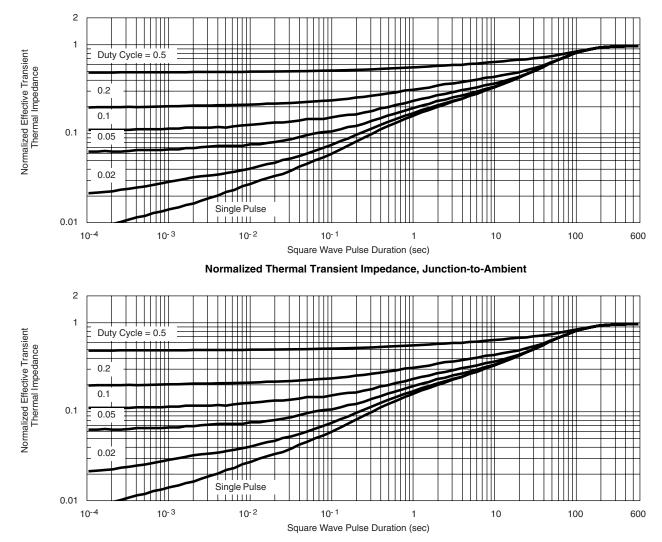
semi

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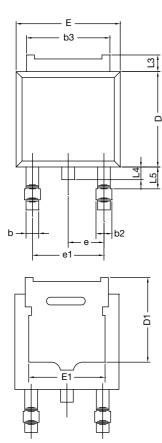
THERMAL RATINGS



Normalized Thermal Transient Impedance, Junction-to-Case



TO-252AA CASE OUTLINE





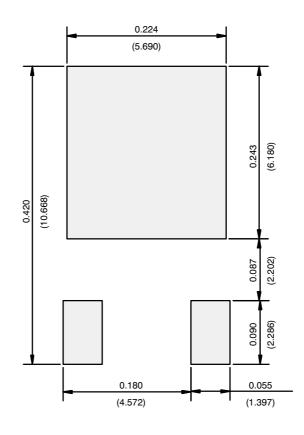
	MILLIN	IETERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
А	2.18	2.38	0.086	0.094	
A1	-	0.127	-	0.005	
b	0.64	0.88	0.025	0.035	
b2	0.76	1.14	0.030	0.045	
b3	4.95	5.46	0.195	0.215	
С	0.46	0.61	0.018	0.024	
C2	0.46	0.89	0.018	0.035	
D	5.97	6.22	0.235	0.245	
D1	5.21	-	0.205	-	
Е	6.35	6.73	0.250	0.265	
E1	4.32	-	0.170	-	
Н	9.40	10.41	0.370	0.410	
е	2.28	BSC	0.090 BSC		
e1	4.56	BSC	0.180 BSC		
L	1.40	1.78	0.055	0.070	
L3	0.89	1.27	0.035	0.050	
L4	-	1.02	-	0.040	
L5	1.14	1.52	0.045	0.060	
ECN: X12- DWG: 5347	0247-Rev. M, 7	24-Dec-12			

Note

• Dimension L3 is for reference only.



RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)



Recommended Minimum Pads Dimensions in Inches/(mm)



Disclaimer

All products due to improve reliability, function or design or for other reasons, product specifications and data are subject to change without notice.

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